Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/644,463	HAYCOCK ET AL.	
Examiner	Art Unit	
Raymond Phan	2111	

Raymond Phan

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED		
Subclass	Date	Examiner
305,106	12/19/2006	RP
82,30	12/19/2006	RP
	:	
	Subclass 305,106	Subclass Date 305,106 12/19/2006

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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